

MOSFET – Dual, N-Channel, POWERTRENCH®

Q1: 30 V, 11.6 m Ω ; Q2: 30 V, 6.4 m Ω

FDMC007N30D

General Description

This device includes two specialized N-Channel MOSFETs in a dual Power33 (3mm \times 3mm MLP) package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous MOSFET (Q2) have been designed to provide optimal power efficiency.

Features

Q1: N-Channel

- Max $R_{DS(on)}$ = 11.6 m Ω at V_{GS} = 10 V, I_D = 10 A
- Max $R_{DS(on)} = 13.3 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 9 \text{ A}$

Q1: N-Channel

- Max $R_{DS(on)} = 6.4 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 16 \text{ A}$
- Max $R_{DS(on)} = 7.0 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 15 \text{ A}$
- RoHS Compliant

Applications

- Mobile Computing
- Mobile Internet Devices
- General Purpose Point of Load

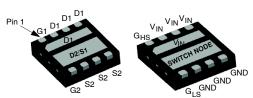
MOSFET MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

Symbol	Parameter	Q1	Q2	Unit
V_{DS}	Drain to Source Voltage	30	30	V
V_{GS}	Gate to Source Voltage (Note 4)	±12	±12	V
I _D	Drain Current: - Continuous, T _C = 25°C (Note 6)	29	46	Α
	 Continuous, T_C = 100°C (Note 6) Continuous, T_A = 25°C (Note 1a) Pulsed (Note 5) 	18 10 (Note 1a) 113	29 16 (Note 1b) 302	
E _{AS}	Single Pulse Avalanche Energy (Note 3)	24	54	mJ
P _D	Power Dissipation for Single Operation: $T_A = 25^{\circ}C$ $T_A = 25^{\circ}C$	1.9 (Note 1a) 0.7 (Note 1c)	2.5 (Note 1b) 1.0 (Note 1d)	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-55 to +150		°C

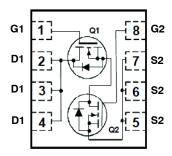
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1

Bottom



WDFN8 3x3 (Power 33) CASE 511DE



Dual N-Channel MOSFET

MARKING DIAGRAM

&Z&2&K FDMC 7N30D

&Z = Assembly Plant Code
&2 = Data Code (Year & Week)
&K = Lot Traceability Code
FDMC7N30D = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping [†]
FDMC007N30D	WDFN-8 (Power 33)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Symbol	Parameter	Q1	Q2	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case	8.2	6.1	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient	65 (Note 1a)	50 (Note 1b)	
		180 (Note 1c)	125 (Note 1d)	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

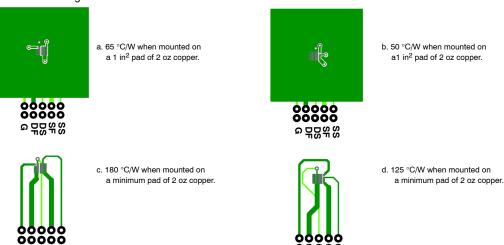
Symbol	Parameter	Test Condition	Туре	Min	Тур	Max	Unit
OFF CHARA	ACTERISTICS		<u>-</u>	<u>-</u>	-	<u>-</u>	
BV _{DSS}	Drain to Source Breakdown Voltage	$\begin{array}{c} I_D = 250 \; \mu A, \; V_{GS} = 0 \; V \\ I_D = 250 \; \mu A, \; V_{GS} = 0 \; V \end{array}$	Q1 Q2	30 30			V
$\Delta BV_{DSS} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25°C I_D = 250 μA, referenced to 25°C	Q1 Q2		15 16		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V	Q1 Q2			1 1	μΑ
I _{GSS}	Gate to Source Leakage Current, Forward	$V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$	Q1 Q2			±100 ±100	nA
ON CHARA	CTERISTICS						
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu A$ $V_{GS} = V_{DS}, I_D = 250 \mu A$	Q1 Q2	1.0 1.0	1.3 1.8	3.0 3.0	V
$rac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25°C I_D = 250 μA, referenced to 25°C	Q1 Q2		-4 -4		mV/°C
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V, } I_D = 10 \text{ A} \\ V_{GS} = 4.5 \text{ V, } I_D = 9 \text{ A} \\ V_{GS} = 10 \text{ V, } I_D = 10 \text{ A, } T_J = 125^{\circ}\text{C}$	Q1		7.7 8.9 10.8	11.6 13.3 16.3	mΩ
R _{DS(on)}	Static Drain to Source On Resistance	V_{GS} = 10 V, I_{D} = 16 A V_{GS} = 4.5 V, I_{D} = 15 A V_{GS} = 10 V, I_{D} = 16 A, T_{J} = 125°C	Q2		4.4 5.4 6.2	6.4 7.0 9.0	mΩ
9FS	Forward Transconductance	V _{DD} = 5 V, I _D = 10 A V _{DD} = 5 V, I _D = 16 A	Q1 Q2		46 70		S
DYNAMIC C	HARACTERISTICS			•	•		•
C _{iss}	Input Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz	Q1 Q2		792 1685	1110 2360	pF
C _{oss}	Output Capacitance		Q1 Q2		230 467	325 655	pF
C _{rss}	Reverse Transfer Capacitance		Q1 Q2		20 36	30 50	pF
R_g	Gate Resistance	f = 1 MHz	Q1 Q2	0.1 0.1	2.0 1.2	4.0 2.4	Ω
SWITCHING	CHARACTERISTICS						
t _{d(on)}	Turn-On Delay Time	Q1 V _{DD} = 15 V, I _D = 10 A,	Q1 Q2		7 10	14 20	ns
t _r	Rise Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	Q1 Q2		2 3	10 10	ns
t _{d(off)}	Turn-Off Delay Time	V _{DD} = 15 V, I _D = 16 A, V _{GS} = 10 V, R _{GEN} = 6 Ω	Q1 Q2		19 24	33 39	ns
t _f	Fall Time		Q1 Q2		2 3	10 10	ns

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Condition	Туре	Min	Тур	Max	Unit
SWITCHING	CHARACTERISTICS		•	•			•
$Q_{g(TOT)}$	Total Gate Charge	$V_{GS} = 0 \text{ V to } 10 \text{ V}$ Q1 $V_{DD} = 15 \text{ V}$, $V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $I_D = 10 \text{ A}$	Q1 Q2		12 24	17 34	nC
			Q1 Q2		5.5 11	7.7 16	nC
Q_{gs}	Gate to Source Charge	Q2 V _{DD} = 15 V, I _D = 16 A	Q1 Q2		1.7 4.4		nC
Q_{gd}	Gate to Drain "Miller" Charge		Q1 Q2		1.3 2.7		nC
DRAIN-SOL	IRCE DIODE CHARACTERISTICS	•					
V _{SD}	Source-Drain Diode Forward Voltage	$ \begin{array}{c} V_{GS} = 0 \text{ V, } I_{S} = 10 \text{ A (Note 2)} \\ V_{GS} = 0 \text{ V, } I_{S} = 1.5 \text{ A (Note 2)} \\ V_{GS} = 0 \text{ V, } I_{S} = 16 \text{ A (Note 2)} \\ V_{GS} = 0 \text{ V, } I_{S} = 2 \text{ A (Note 2)} \\ \end{array} $	Q1 Q1 Q2 Q2		0.85 0.75 0.83 0.73	1.2 1.2 1.2 1.2	V
t _{rr}	Reverse Recovery Time	Q1 I _F = 10 A, di/dt = 100 A/μs	Q1 Q2		17 27	31 42	ns
Q _{rr}	Reverse Recovery Charge	Q2 I _F = 16 A, di/dt = 100 A/μs	Q1 Q2		5 10	10 20	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 \times 1.5 in. board of FR-4 material. $R_{\theta CA}$ is determined by the user's board design.



- Pulse Test: Pulse Width < 300 uS, Duty cycle < 2.0%.
 Q1: E_{AS} of 24 mJ is based on starting T_J = 25°C, L = 3 mH, I_{AS} = 4 A, V_{DD} = 30 V, V_{GS} = 10 V. 100% tested at L = 0.1 mH, I_{AS} = 13 A. Q2: E_{AS} of 54 mJ is based on starting T_J = 25°C, L = 3 mH, I_{AS} = 6 A, V_{DD} = 30 V, V_{GS} = 10 V. 100% tested at L = 0.1 mH, I_{AS} = 22 A.
 As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.
 Pulse Test: Pulse Width < 300 uS, Duty cycle < 2.0%.
 Pulse Test: Pulse Width < 300 uS, Duty cycle < 2.0%.

- 6. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

TYPICAL CHARACTERISTICS (Q1 N-CHANNEL)

(T_{.I} = 25°C UNLESS OTHERWISE NOTED)

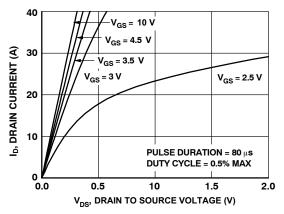
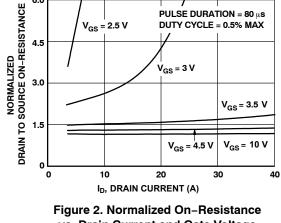


Figure 1. On Region Characteristics



vs. Drain Current and Gate Voltage

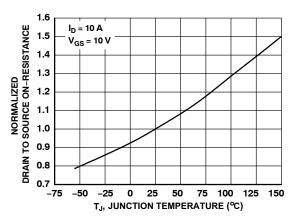


Figure 3. Normalized On Resistance vs. Junction Temperature

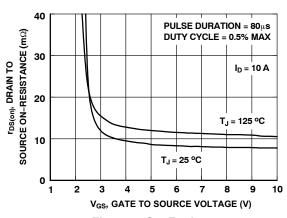


Figure 4. On-Resistance vs. Gate to Source Voltage

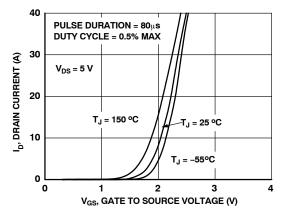


Figure 5. Transfer Characteristics

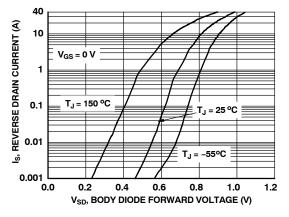


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (Q1 N-CHANNEL) (CONTINUED)

(T_J = 25°C UNLESS OTHERWISE NOTED)

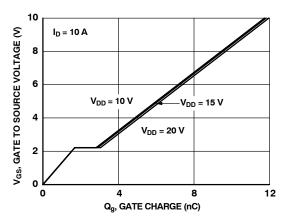


Figure 7. Gate Charge Characteristics

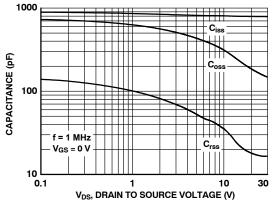


Figure 8. Capacitance vs. Drain to Source Voltage

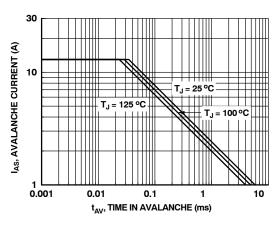


Figure 9. Unclamped Inductive Switching Capability

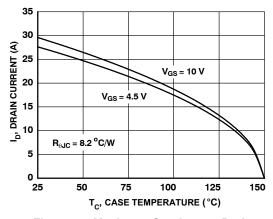


Figure 10. Maximum Continuous Drain Current vs. Case Temperature

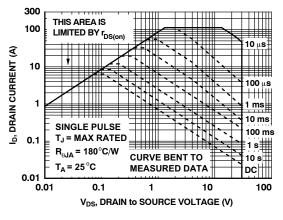


Figure 11. Forward Bias Safe Operating Area

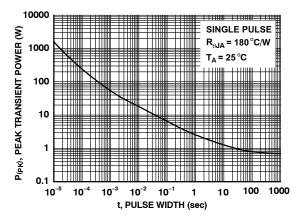


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (Q1 N-CHANNEL) (CONTINUED)

(T_J = 25°C UNLESS OTHERWISE NOTED)

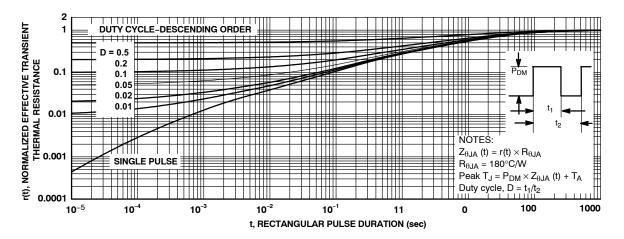


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

TYPICAL CHARACTERISTICS (Q2 N-CHANNEL)

(T_{.I} = 25°C UNLESS OTHERWISE NOTED)

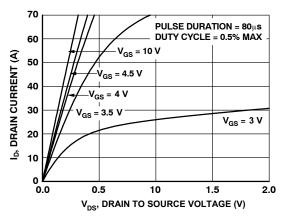


Figure 14. On Region Characteristics

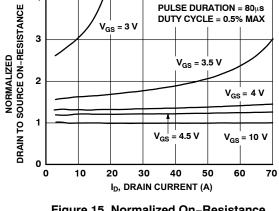


Figure 15. Normalized On-Resistance vs. Drain Current and Gate Voltage

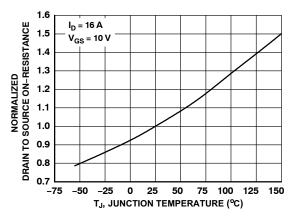


Figure 16. Normalized On Resistance vs. Junction Temperature

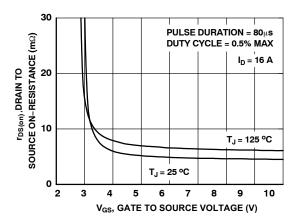


Figure 17. On-Resistance vs. Gate to Source Voltage

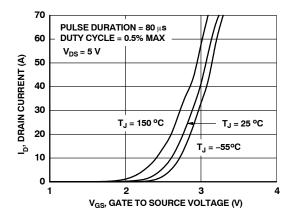


Figure 18. Transfer Characteristics

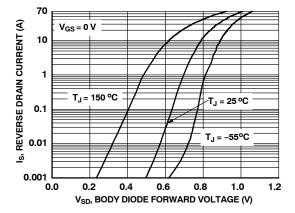


Figure 19. Source to Drain Diode Forward Voltage vs. Source Current

TYPICAL CHARACTERISTICS (Q2 N-CHANNEL) (CONTINUED)

(T_{.I} = 25°C UNLESS OTHERWISE NOTED)

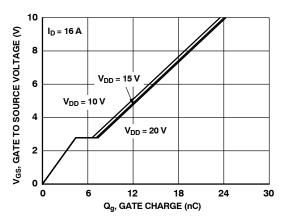


Figure 20. Gate Charge Characteristics

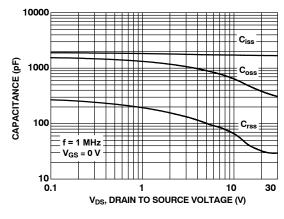


Figure 21. Capacitance vs. Drain to Source Voltage

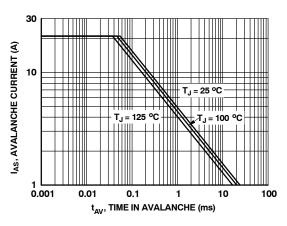


Figure 22. Unclamped Inductive Switching Capability

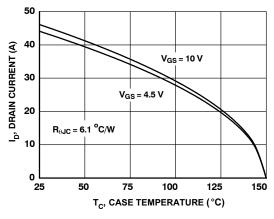


Figure 23. Maximum Continuous Drain Current vs. Case Temperature

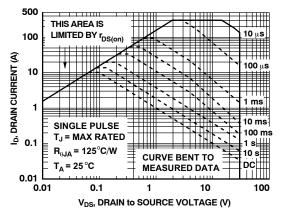


Figure 24. Forward Bias Safe Operating Area

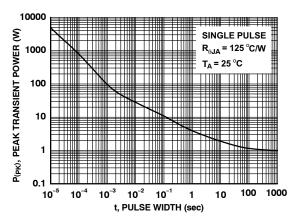


Figure 25. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (Q2 N-CHANNEL) (CONTINUED)

(T_J = 25°C UNLESS OTHERWISE NOTED)

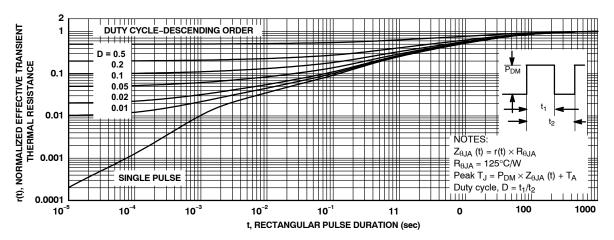
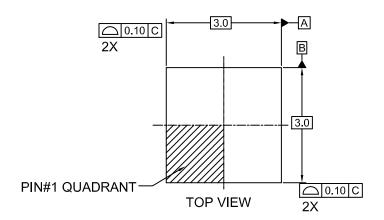
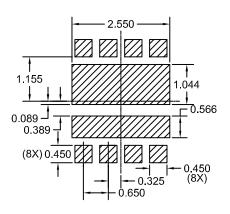


Figure 26. Junction-to-Ambient Transient Thermal Response Curve

WDFN8 3x3, 0.65P CASE 511DE ISSUE O

DATE 31 AUG 2016





RECOMMENDED LAND PATTERN

PIN #1 IDENT (8X) 0.37 1 4 0.57 0.47 0.41 0.06 1.04 0.94 0.94 0.94 0.10() C A B 0.05() C

NOTES:

- A. DOES NOT CONFORM TO JEDEC REGISTRATION MO-229
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994

BOTTOM VIEW

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